

<b>Notice of References Cited</b>	Application/Control No. 10/815,106		Applicant(s)/Patent Under Reexamination ICHIKAWA ET AL.	
	Examiner Shin-Hon Chen		Art Unit 2131	Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2003/0212888	11-2003	Wildish et al.	713/158
*	B	US-6,910,128	06-2005	Skibbie et al.	713/170
*	C	US-6,766,353	07-2004	Lin et al.	709/203
*	D	US-2003/0079125	04-2003	Hope et al.	713/156
*	E	US-6,993,665	01-2006	Heddings et al.	726/21
*	F	US-6,526,513	02-2003	Shrader et al.	726/4
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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	V	
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	X	

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